REV. 1.7 FS8205A-DS-17_EN AUG 2016

Datasheet

FS8205A

Dual N-Channel Enhancement Mode Power MOSFET



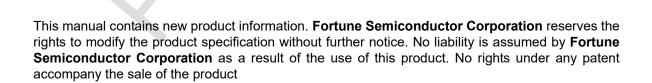


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1. Features

1.1 Low on-resistance

1.1.1 $R_{DS(ON)} = 28 \text{ m}\Omega$ MAX. $(V_{GS} = 4.5V, I_D = 4A)$

1.1.2 $R_{DS(ON)} = 37 \text{ m}\Omega$ MAX. $(V_{GS} = 2.5V, I_D = 3A)$

2. Applications

■ Li-ion battery management applications

3. Ordering Information

Product Number	Description	Package Type	Quantity/Reel
FS8205A	TSSOP8 package version	TSSOP-8	3,000

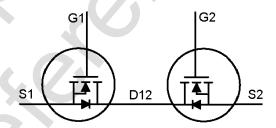
4. Pin Assignment



A: A~Z or $\underline{A} \sim \underline{Z}$ B: A~Z or $\underline{A} \sim \underline{Z}$ C: A~Z or $\underline{A} \sim \underline{Z}$ or 0~9 ABCCC: Lot no information

TSSOP-8 Top View

		•		
D12 🗖	1		8	□ D12
S1 □	2		7	⊐ S2
S1 □	3		6	⊐ S2
G1⊏	4 <		5	□ G2



5. Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	
VDS	Drain-Source Voltage	20	V	
VGS	Gate-Source Voltage	±12	V	
ID @TA = 25°C	Continuous Drain Current3	6	Α	
ID @TA = 70°C	Continuous Drain Current3	5	Α	
IDM	Pulsed Drain Current1	25	Α	
PD @TA = 25°C	Total Power Dissipation	1	W	
	Linear Derating Factor	0.008	W/°C	
TSTG	Storage Temperature Range	-55 to 150	$^{\circ}\!\mathbb{C}$	
TJ	Operating Junction Temperature Range	-55 to 150 °C		



Thermal Data 6.

Symbol	Parameter		Value	Unit
Rthj-a	Thermal Resistance Junction-ambient3	Max.	125	°C/W

Electrical Characteristics 7.

Electrical Characteristics $@T_i = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Static Character	ristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250uA$	20	-	-	V
$\Delta BV_{DSS}/\Delta T_{j}$	Breakdown Voltage Temperature Coefficient Reference to 25℃, I _D =1mA - 0.1				-	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance ²	$V_{GS} = 4.5V, I_D = 4A$	-	23	28	$m\Omega$
		$V_{GS} = 2.5V, I_D = 3A$	-	30	37	$m\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250uA$	0.45	-	1.2	V
l	Drain-Source Leakage Current (T _j = 25°C)	$V_{DS} = 16V, V_{GS} = 0V$	•	-	1	uA
I _{DSS}	Drain-Source Leakage Current (T _j = 70°C)	$V_{DS} = 16V, V_{GS} = 0V$	-	-	25	uA
I _{GSS}	Gate-Source Leakage	$V_{GS} = \pm 10V$	-	-	±0.1	uA

Source-Drain Diode 8.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Is	Continuous Source Current (Body Diode)	$V_D = V_G = 0V, V_S = 1.2V$	1)-	0.83	Α
V_{SD}	Forward On Voltage ²	$T_j = 25^{\circ}C$, $I_S = 1.25A$, $V_{GS} = 0V$		_	1.2	V

Notes:

- 1. Pulse width limited by Max. junction temperature. 2. Pulse width \leq 300us, duty cycle \leq 2%.
- 3. Surface mounted on 1 in2 copper pad of FR4 board; 208°C/W when mounted on Min. copper pad.

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9. Typical Characteristics

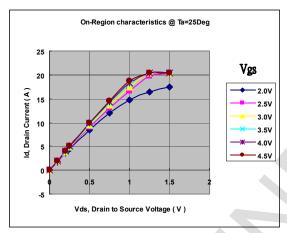


Fig 1. Typical Output Characteristics

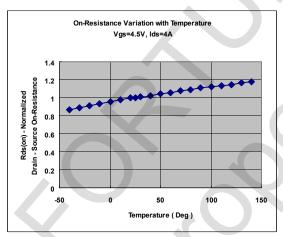


Fig 3. Normalized On-Resistance

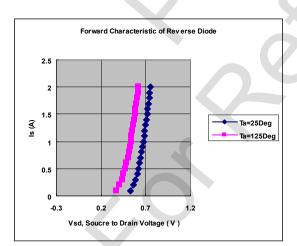


Fig 5. Forward Characteristic of Reverse Diode

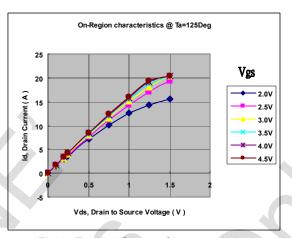


Fig 2. Typical Output Characteristics

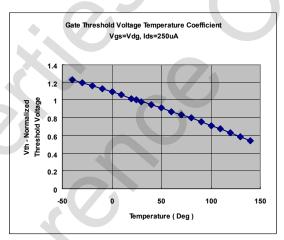
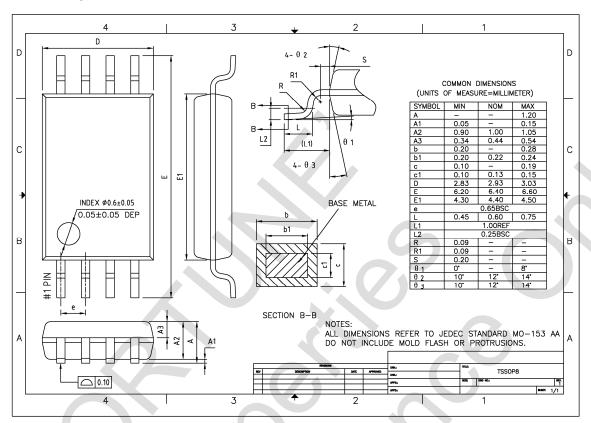


Fig 4. Gate Threshold Variation with Temperature



10. Package Information



11. Revision History

Version	Date	Page	Description
1.0	2009/02/10		Version 1.0 released
1.1	2009/04/28	3~4	Rds25 TYP 25mohm MAX 32mohm
			Rds45 TYP 20mohm MAX 25mohm
			ID @TA = 25°C 6A
			ID @TA = 70°C 5A
			ID pulse 300 μ S 25A
1.2	2009/08/04	3~4	Rds25 TYP 27mohm MAX 35mohm
			Rds45 TYP 21mohm MAX 25mohm
			Rds25 ID: 3A
			Rds45 ID: 4A
1.3	2010/06/02	3~4	Rds45 TYP 22mohm MAX 27mohm
1.4	2010/06/10	4	IDSS Test Conditions : VDS=16V VGS=0V
1.5	2011/04/27	4	Rds25 TYP: 30mohm MAX: 37mohm
			Rds45 TYP: 23mohm MAX: 28mohm
			VGS(th) MIN: 0.45V MAX: 1.2V
			IGSS MAX: ±0.1uA
1.6	2014/05/22	2	Revised company address
1.7	2016/08/22	3	Revise Package Marking Information